

UTC UNISONIC TECHNOLOGIES CO., LTD

## 75NM70

Preliminary

# 75A, 700V N-CHANNEL SUPER-JUNCTION MOSFET

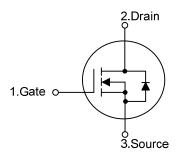
### DESCRIPTION

The UTC 75NM70 is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

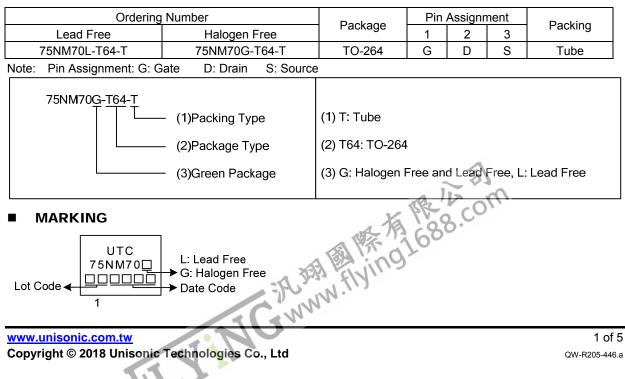
#### **FEATURES**

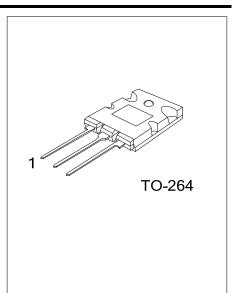
- \* R<sub>DS(ON)</sub> < 70mΩ @ V<sub>GS</sub> = 10V, I<sub>D</sub> = 37.5A
- \* Fast switching capability
- \* Avalanche energy tested
- \* Improved dv/dt capability, high ruggedness

### SYMBOL



**ORDERING INFORMATION** 





#### ABSOLUTE MAXIMUM RATINGS (Tc =25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V <sub>DSS</sub>	700	V	
Gate-Source Voltage		V <sub>GSS</sub>	±30	V	
Drain Current	Continuous	I <sub>D</sub>	75	А	
	Pulsed (Note 2)	I <sub>DM</sub>	150	А	
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	922	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	15	V/ns	
Power Dissipation		PD	255	W	
Junction Temperature		ΤJ	+150	°C	
Storage Temperature Range		T <sub>STG</sub>	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=5mH,  $I_{AS}$ =19.2A,  $V_{DD}$ =50V,  $R_G$ =25 $\Omega$ , Starting  $T_J$  = 25°C.
- 4.  $I_{SD} \leq 30A$ , di/dt  $\leq 200A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J = 25^{\circ}C$ .

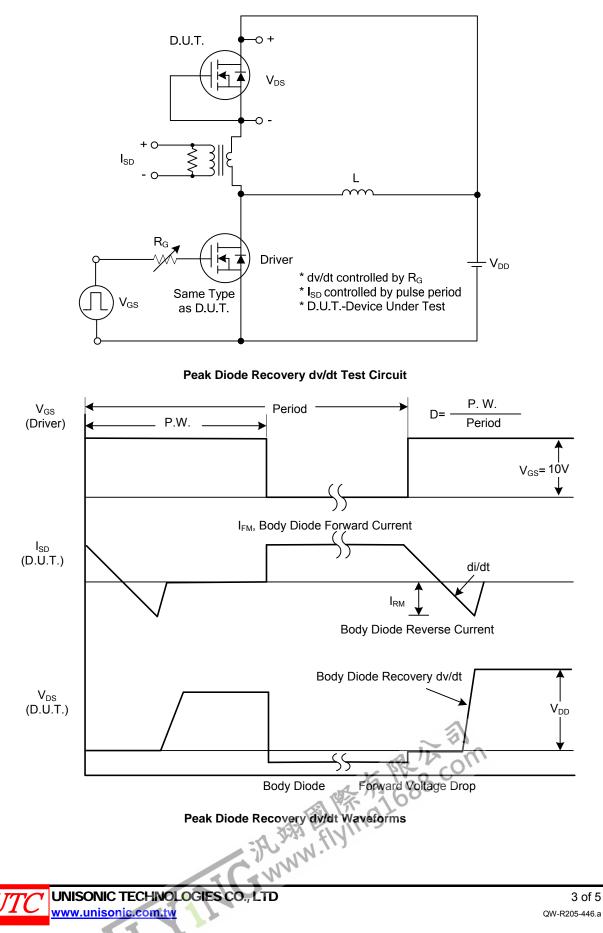
#### THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	$\theta_{JA}$	40	°C/W	
Junction to Case	θ <sub>JC</sub>	0.4	°C/W	

#### ELECTRICAL CHARACTERISTICS (TJ=25°C, unless otherwise specified)

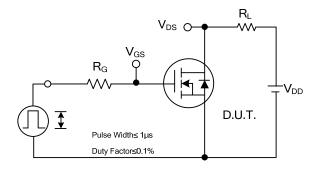
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT					
OFF CHARACTERISTICS											
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250µA	700			V					
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =700V, V <sub>GS</sub> =0V			10	μA					
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =0V ,V <sub>GS</sub> =±30V			±100	nA					
ON CHARACTERISTICS											
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.5		4.5	V					
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 37.5A			70	mΩ					
DYNAMIC PARAMETERS											
Input Capacitance	CISS			5000		рF					
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHz		2500		рF					
Reverse Transfer Capacitance				7		рF					
SWITCHING PARAMETERS											
Total Gate Charge (Note 1)	$Q_{G}$			205		nC					
Gate to Source Charge	Q <sub>GS</sub> V <sub>DS</sub> =300V, V <sub>GS</sub> =75V,			48		nC					
Gate to Drain Charge	$Q_{GD}$	$I_D = 1.3A$ , $I_G = 111A$ (Note 1, 2)		88		nC					
Turn-ON Delay Time (Note 1)	t <sub>D(ON)</sub>			96		ns					
Rise Time	t <sub>R</sub>	V <sub>DD</sub> =300V, V <sub>GS</sub> =10V,		62		ns					
Turn-OFF Delay Time	-OFF Delay Time $t_{D(OFF)}$ I <sub>D</sub> =30A, R <sub>G</sub> =25 $\Omega$ (Note			680		ns					
Fall-Time	t⊨			220		ns					
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS											
Maximum Body-Diode Continuous Current	ls	3			75	Α					
Maximum Body-Diode Pulsed Current	I <sub>SM</sub>		0		150	Α					
Drain-Source Diode Forward Voltage (Note 1)	V <sub>SD</sub>	I <sub>S</sub> =75A, V <sub>GS</sub> =0V	1.		1.4	V					
Body Diode Reverse Recovery Time (Note 1)	t <sub>rr</sub>	I <sub>S</sub> =30A, V <sub>GS</sub> =0V, <b>O</b>		770		ns					
Body Diode Reverse Recovery Charge	Qrr	dl <sub>F</sub> /dt=100A/µs		18		μC					
Notes: 1. Pulse Test : Pulse width $\leq$ 300µs, Duty cycle $\leq$ 2%.											
2. Essentially independent of operating temperature.											
Body Didde Reverse Recovery Charge Q <sub>m</sub> Querce roc×ps 18 μC   Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%. 2. Essentially independent of operating temperature. 2.											
- WY											

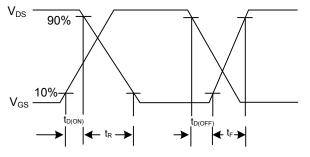
### TEST CIRCUITS AND WAVEFORMS



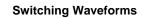
## 75NM70

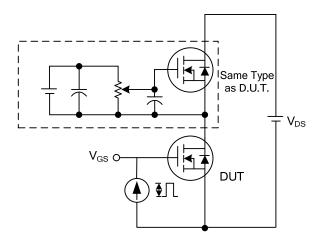
### **TEST CIRCUITS AND WAVEFORMS (Cont.)**



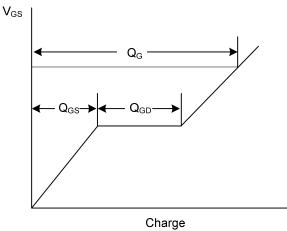


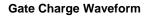
Switching Test Circuit

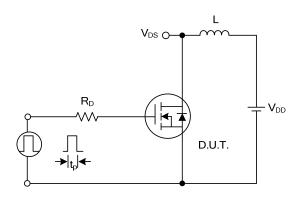




**Gate Charge Test Circuit** 







 $\mathsf{BV}_{\mathsf{DSS}}$  $I_{AS}$ D(t) V<sub>DS(t)</sub>  $V_{DD}$ it Unclamped Inductive Switching Waveforms



**Unclamped Inductive Switching Test Circuit** 

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